

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.

71247-0064

SERIAL NO.

10/589,137

APPLICANT

Chouki AKTOUF

FILING DATE

08/07/2008

GROUP ART UNIT

2825

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	1.	2003/0023941	01/30/2003	WANG et al.			
	2.	6,256,770	07/03/2001	PIERCE et al.			

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION		
							YES	NO	PART.

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	3.	Y. HUANG et al., "On RTL Scan Design", ITC International Test Conference, Baltimore, Maryland, October 30-November 1, 2001, IEEE, US, pgs. 728-737
	4.	C. AKTOUF et al., "Inserting Scan at the Behavioral Level", IEEE Design & Test of Computers, vol. 17, no. 3, July 2000, pgs. 34-42

EXAMINER

/Brandon Bowers/

DATE CONSIDERED

09/29/2010

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /BB/